

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/584,812	ALVAREZ, LUIS MARQUEZ	
Examiner		Michael J. Araj	Art Unit	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0143341	10-2002	Biedermann et al.	606/73
*	B	US-5,882,350	03-1999	Ralph et al.	606/61
*	C	US-6,723,100	04-2004	Biedermann et al.	606/73
*	D	US-5,782,833	07-1998	Haider, Thomas T.	606/61
*	E	US-RE37,665	04-2002	Ralph et al.	606/61
*	F	US-6,371,957	04-2002	Amrein et al.	606/61
*	G	US-6,063,090	05-2000	Schlapfer, Fridolin	606/61
*	H	US-6,835,196	12-2004	Biedermann et al.	606/61
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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